Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/812,947	YOSHIDA, SEIKOH	
Examiner	Art Unit	

Monica Lewis

2822

SEARCHED					
Class	Subclass	Date	Examiner		
257	76-78, 213-413, 900,902, 903	3/26/2007	ML		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EIC Search	·	3/26/2007	ML
East Search		3/26/2007	ML
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